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FEATURES

- Avalanche Rugged Technology
- Rugged Gate Oxide Technology
- Lower Input Capacitance
- Improved Gate Charge
- Extended Safe Operating Area
- Lower Leakage Current : 10 μ A (Max.) @ $V_{DS} = -100V$
- Lower $R_{DS(ON)}$: 0.912 Ω (Typ.)

$BV_{DSS} = -100\text{ V}$

$R_{DS(on)} = 1.2\ \Omega$

$I_D = -1.0\text{ A}$

SOT-223



1. Gate 2. Drain 3. Source

Absolute Maximum Ratings

Symbol	Characteristic	Value	Units
V_{DSS}	Drain-to-Source Voltage	-100	V
I_D	Continuous Drain Current ($T_A=25^{\circ}\text{C}$)	-1.0	A
	Continuous Drain Current ($T_A=70^{\circ}\text{C}$)	-0.7	
I_{DM}	Drain Current-Pulsed ①	-8.0	A
V_{GS}	Gate-to-Source Voltage	± 30	V
E_{AS}	Single Pulsed Avalanche Energy ②	53	mJ
I_{AR}	Avalanche Current ①	-1.0	A
E_{AR}	Repetitive Avalanche Energy ①	0.25	mJ
dv/dt	Peak Diode Recovery dv/dt ③	-6.5	V/ns
P_D	Total Power Dissipation ($T_A=25^{\circ}\text{C}$) *	2.52	W
	Linear Derating Factor *	0.02	W/ $^{\circ}\text{C}$
T_J, T_{STG}	Operating Junction and Storage Temperature Range	- 55 to +150	$^{\circ}\text{C}$
T_L	Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5-seconds	300	

Thermal Resistance

Symbol	Characteristic	Typ.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient *	--	50	$^{\circ}\text{C/W}$

* When mounted on the minimum pad size recommended (PCB Mount).

Electrical Characteristics ($T_C=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
BV_{DSS}	Drain-Source Breakdown Voltage	-100	--	--	V	$V_{GS}=0V, I_D=-250\mu A$
$\Delta BV/\Delta T_J$	Breakdown Voltage Temp. Coeff.	--	-0.1	--	$V/^{\circ}\text{C}$	$I_D=-250\mu A$ See Fig 7
$V_{GS(th)}$	Gate Threshold Voltage	-2.0	--	-4.0	V	$V_{DS}=-5V, I_D=-250\mu A$
I_{GSS}	Gate-Source Leakage, Forward	--	--	-100	nA	$V_{GS}=-20V$
	Gate-Source Leakage, Reverse	--	--	100		$V_{GS}=20V$
I_{DSS}	Drain-to-Source Leakage Current	--	--	-10	μA	$V_{DS}=-100V$
		--	--	-100		$V_{DS}=-80V, T_C=125^{\circ}\text{C}$
$R_{DS(on)}$	Static Drain-Source On-State Resistance	--	--	1.2	Ω	$V_{GS}=-10V, I_D=-0.5A$ ④
g_{fs}	Forward Transconductance	--	1.3	--	S	$V_{DS}=-40V, I_D=-0.5A$ ④
C_{iss}	Input Capacitance	--	260	335	pF	$V_{GS}=0V, V_{DS}=-25V, f=1\text{MHz}$ See Fig 5
C_{oss}	Output Capacitance	--	50	80		
C_{rss}	Reverse Transfer Capacitance	--	17	25		
$t_{d(on)}$	Turn-On Delay Time	--	10	30	ns	$V_{DD}=-50V, I_D=-3.6A,$ $R_G=24\Omega$ See Fig 13 ④⑤
t_r	Rise Time	--	20	50		
$t_{d(off)}$	Turn-Off Delay Time	--	25	60		
t_f	Fall Time	--	12	35		
Q_g	Total Gate Charge	--	9	10	nC	$V_{DS}=-80V, V_{GS}=-10V,$ $I_D=-3.6A$ See Fig 6 & Fig 12 ④⑤
Q_{gs}	Gate-Source Charge	--	1.5	--		
Q_{gd}	Gate-Drain("Miller") Charge	--	4.3	--		

Source-Drain Diode Ratings and Characteristics

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
I_S	Continuous Source Current	--	--	-1.0	A	Integral reverse pn-diode in the MOSFET
I_{SM}	Pulsed-Source Current ①	--	--	-8.0		
V_{SD}	Diode Forward Voltage ④	--	--	-3.8	V	$T_J=25^{\circ}\text{C}, I_S=-1.0A, V_{GS}=0V$
t_{rr}	Reverse Recovery Time	--	100	--	ns	$T_J=25^{\circ}\text{C}, I_F=-3.6A$
Q_{rr}	Reverse Recovery Charge	--	0.35	--	μC	$di_F/dt=100A/\mu s$ ④

Notes ;

① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature

② $L=80\text{mH}, I_{AS}=-1.0A, V_{DD}=-25V, R_G=27\Omega^*,$ Starting $T_J=25^{\circ}\text{C}$ ③ $I_{SD}\leq -3.6A, di/dt\leq 300A/\mu s, V_{DD}\leq BV_{DSS},$ Starting $T_J=25^{\circ}\text{C}$ ④ Pulse Test : Pulse Width = $250\mu s,$ Duty Cycle $\leq 2\%$

⑤ Essentially Independent of Operating Temperature

Fig 1. Output Characteristics

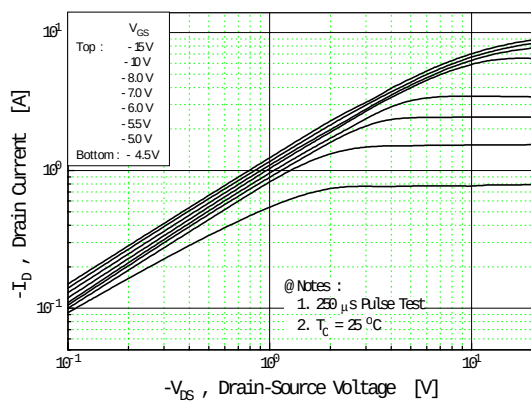


Fig 2. Transfer Characteristics

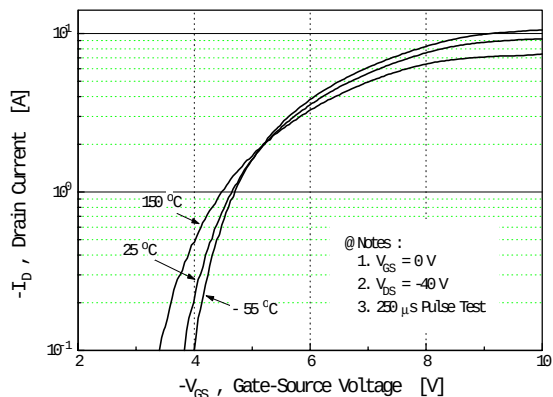


Fig 3. On-Resistance vs. Drain Current

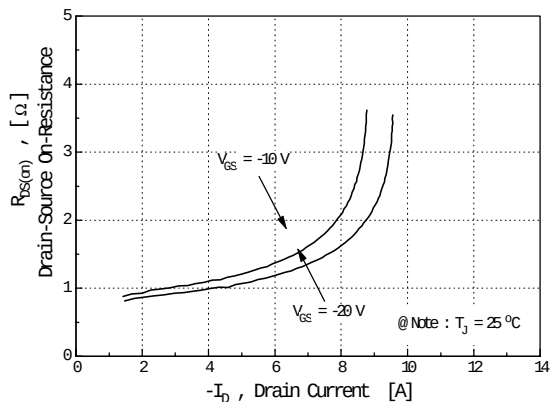


Fig 4. Source-Drain Diode Forward Voltage

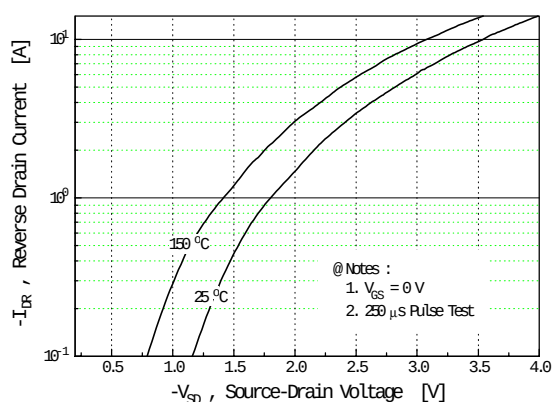


Fig 5. Capacitance vs. Drain-Source Voltage

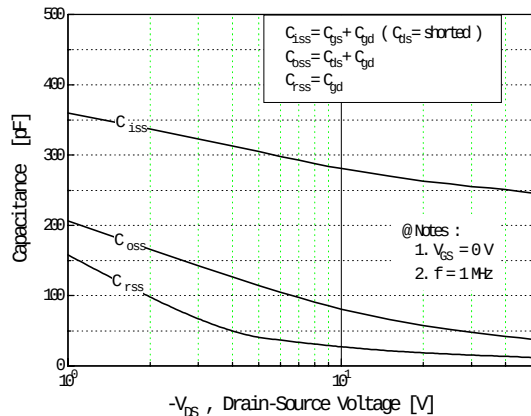


Fig 6. Gate Charge vs. Gate-Source Voltage

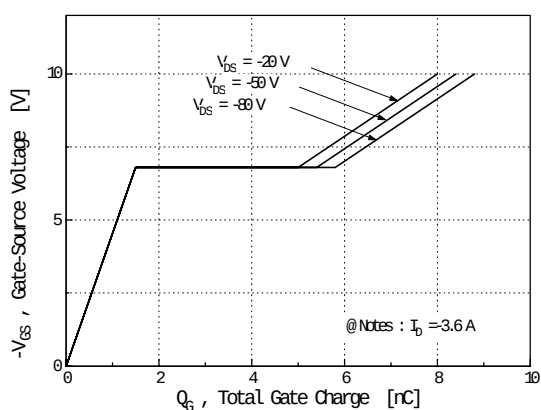


Fig 7. Breakdown Voltage vs. Temperature

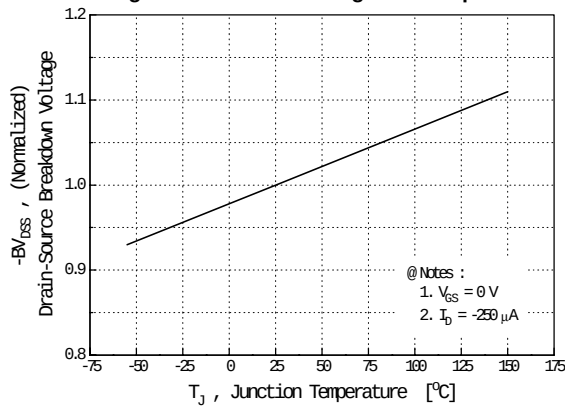


Fig 8. On-Resistance vs. Temperature

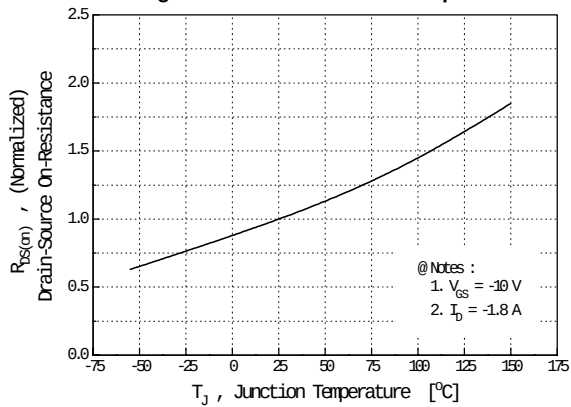


Fig 9. Max. Safe Operating Area

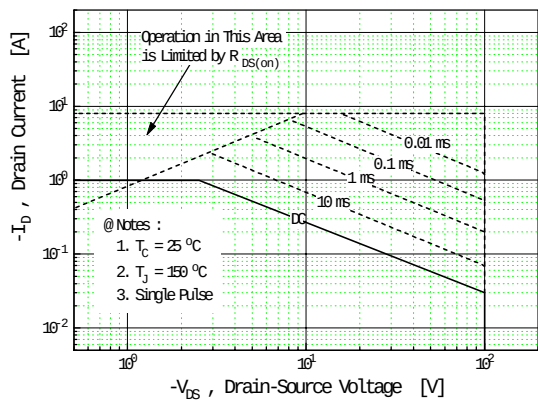


Fig 10. Max. Drain Current vs. Case Temperature

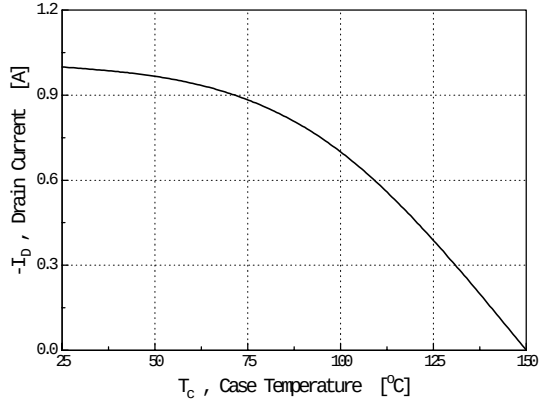


Fig 11. Thermal Response

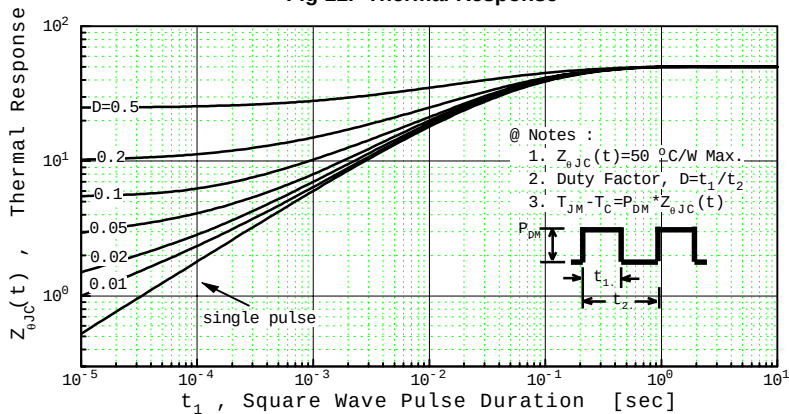


Fig 12. Gate Charge Test Circuit & Waveform

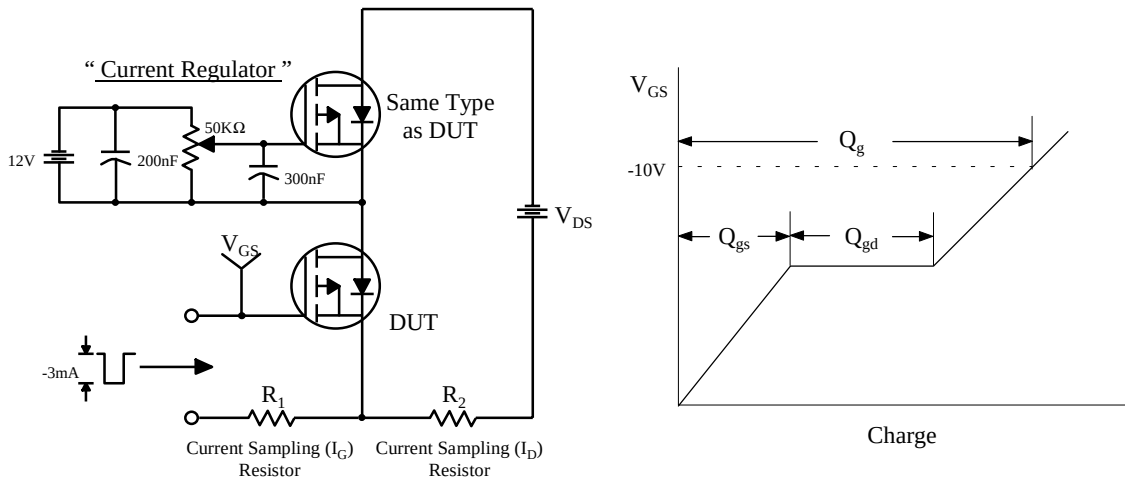


Fig 13. Resistive Switching Test Circuit & Waveforms

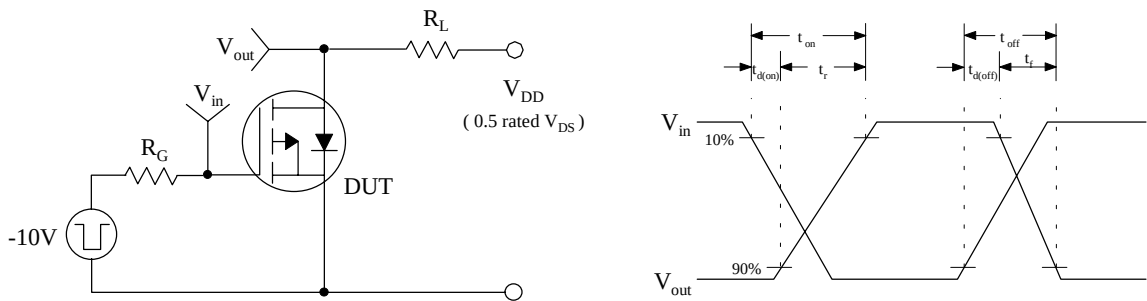


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

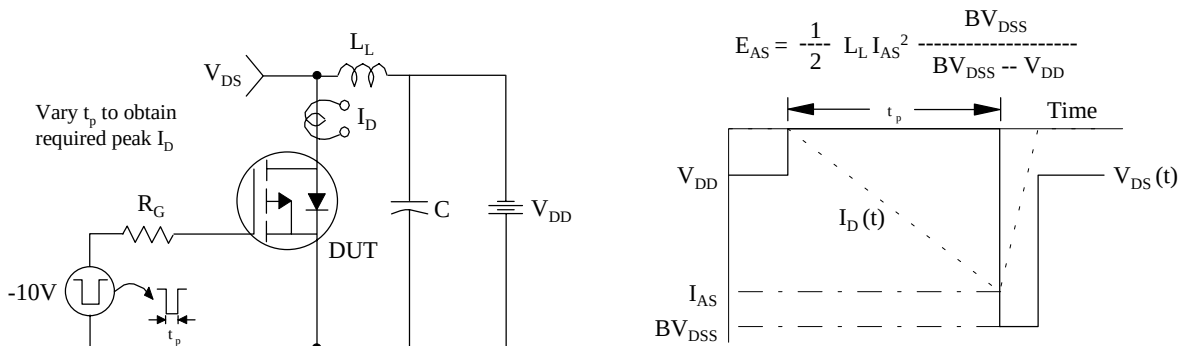
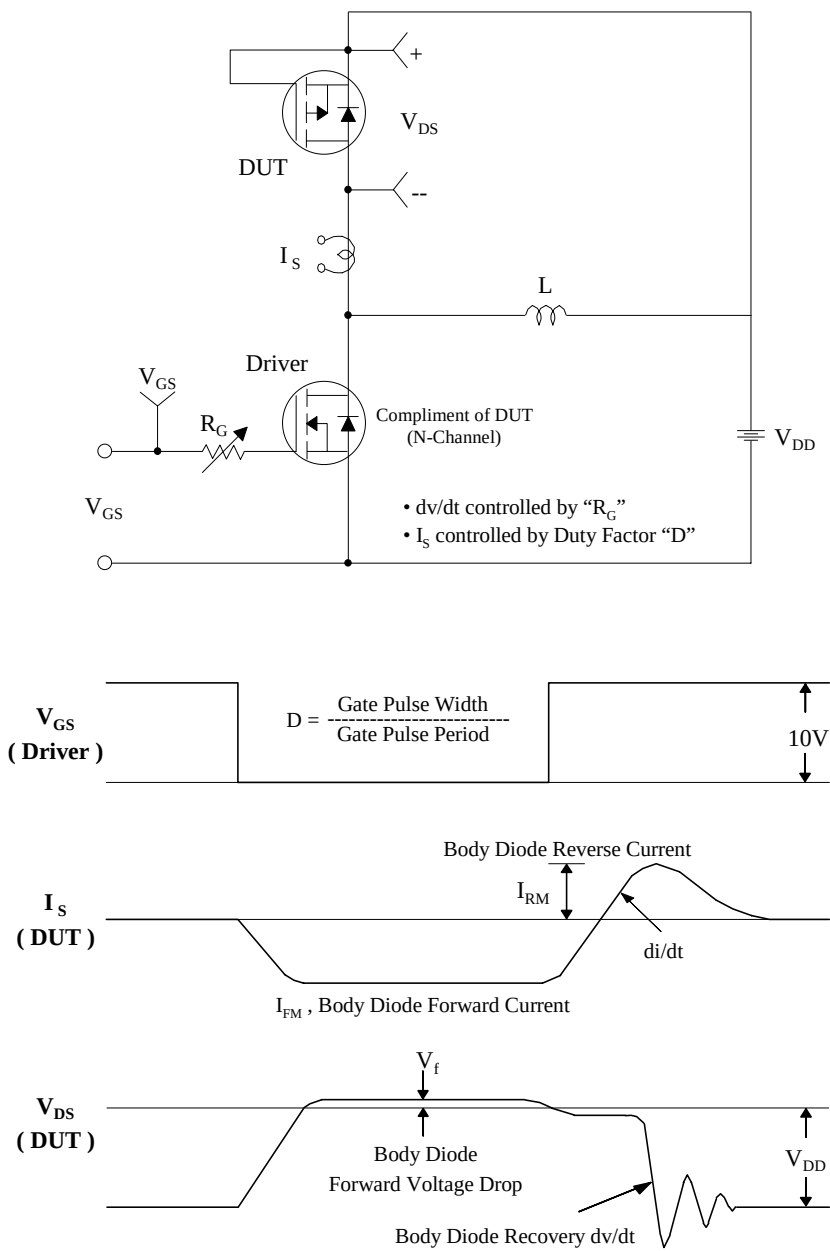


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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